

Search Notes

Application No.

10/742,897

Examiner

Hau V Phan

Applicant(s)

ALSTER ET AL.

Art Unit

3618

SEARCHED

Class	Subclass	Date	Examiner
180	65.9 65.1 65.2 65.6	11/4/2005	HP
	65.7 65.5		
307	64	11/4/2005	HP
	84		
74	661	11/4/2005	HP
	665B		
416	125	11/4/2005	HP
	129		
244	121	11/4/2005	HP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner